,	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/879,575	REEDS ET AL.
Examiner	Art Unit
Ellen C. Tran	2134

SEARCHED			
Class	Subclass	Date	Examiner
380	37	5/11/2007	ECT
380	274	5/11/2007	ECT
713	150, 168	5/11/2007	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPG, USPTO, EPO, JPO, DERWEINT, IBM TECH DES	5/11/2007	ECT
NPL - IEEE XPLORE	5/11/2007	ECT
All claims were reviewed for possible 101 rejections	5/11/2007	ECT
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